## Notice of References Cited Application/Control No. 10/564,908 Applicant(s)/Patent Under Reexamination HENN ET AL. Examiner Art Unit HIEU T. VO 3747 Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,467,442 B2	10-2002	Russell et al.	123/295
*	В	US-6,282,485 B1	08-2001	Kotwicki et al.	701/104
*	С	US-5,143,111 A	09-1992	Durbin, Enoch J.	123/527
*	D	US-4,944,271 A	07-1990	Iwata et al.	123/494
*	E	US-4,866,620 A	09-1989	Abe et al.	701/103
	F	US-			
	G	US-		•	
	Н	US-			
	1	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	Р					
	Q					
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	s					
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## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.